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## **LIST OF PATENTS** AND PUBLICATIONS

**APPLICANT** 

14520 138 (111-17-10 C.4 JUL 2005

**Ewald HAGEN et al** 

**FILING DATE** 

concurrently herewith

GROUP

## **U.S. PATENT DOCUMENTS**

EX. INIT		DOCUMENT NO. Cntry code - No.	DATE MM-YYYY	NAME	CLASS	SUB-CLASS	FILING DATE
	AA	US-3 362 208	01-1968	Murphy et al.			
	ВВ	US-3 709 013	01-1975	Petsch			
	СС	US-		-			
	DD	US-				-	
	EE	US-					
	FF	US-		-			
	GG	US-		-			
	нн	us-					

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	TRANSL.	
	Cntry Code - No.	MM-YYYY	į			YES	NO
 Al	GB 929 056	06-1963	Great Britain				
 AJ							
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AL							
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AO							
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## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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